

# Search Notes



Application/Control No.

10/805,048

Examiner

Hiep Nguyen

Applicant(s)/Patent under Reexamination

LIN, JYH CHAIN

Art Unit

2816

## SEARCHED

Class	Subclass	Date	Examiner
327	108	06.13.05	HN
	109	↓	↓
	110		
326	82		
	83		
327	143		
	323	↓	↓

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST	06.13.05	HN
See attachment		